

UNISONIC TECHNOLOGIES CO., LTD

2NM50 Preliminary Power MOSFET

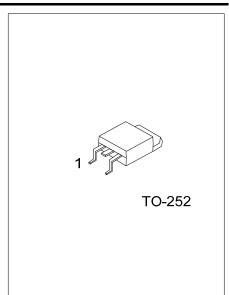
2.0A, 500V N-CHANNEL SUPER-JUNCTION MOSFET

■ DESCRIPTION

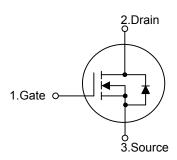
The **UTC 2NM50** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

■ FEATURES

- * $R_{DS(ON)}$ < 2.10 @ V_{GS} =10V, I_{D} =1.0A
- * High Switching Speed
- * 100% Avalanche Tested



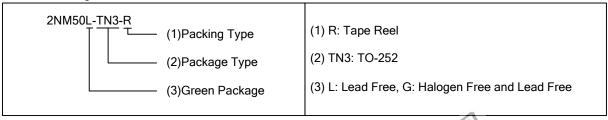
■ SYMBOL



■ ORDERING INFORMATION

Ordering Number		Daakana	Pin	Assignm	Deeking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
2NM50L-TN3-R	2NM50G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	500	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous	I _D 1.0		Α
	Pulsed (Note 2)	I _{DM}	8.0	Α
Avalanche Current (Note 2)		I _{AR}	1.1	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	87	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	5.56	V/ns
Power Dissipation		P_D	50	W
Junction Temperature		T_J	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=144mH, I_{AS} =1.1A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25°C.
- 4. I_{SD}≤2.0A, di/dt≤200A/µs, V_{DD}≤BV_{DSS}, Starting T_J=25°C.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	θ_{JC}	2.5	°C/W	

■ **ELECTRICAL CHARACTERISTICS** (T_J =25°C, unless otherwise noted)

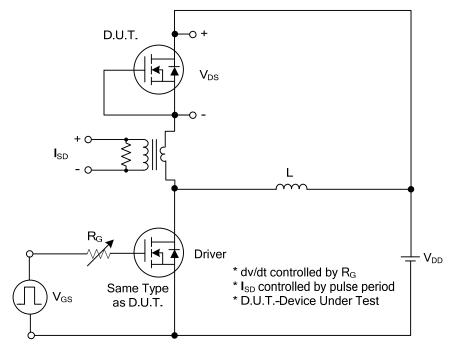
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	500			V	
Drain-Source Leakage Current		I_{DSS}	V _{DS} =500V, V _{GS} =0V			25	μΑ	
Gate- Source Leakage Current	Forward	1	V _{GS} =+30V, V _{DS} =0V			+100	nA	
	Reverse	I_{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.5		4.5	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =1.0A			2.1	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		C _{ISS}			135		pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		120		pF	
Reverse Transfer Capacitance		C_{RSS}			21		pF	
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)		Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A,		20		nC	
Gate to Source Charge		Q_{GS}	I _G =100μA (Note 1, 2)		3.5		nC	
Gate to Drain Charge		Q_GD	IG-100μA (Note 1, 2)		6		nC	
Turn-ON Delay Time (Note 1)		t _{D(ON)}			36		ns	
Rise Time		t_R	$V_{DD} = 30V, V_{GS} = 10V, I_{D} = 0.5A,$		48		ns	
Turn-OFF Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		72		ns	
Fall-Time		t_{F}			34		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is	WE ON			2	Α	
Maximum Body-Diode Pulsed Current		I _{SM}	18 108			8	Α	
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =2.0A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =2.0A, V _{GS} =0V,		170		ns	
Body Diode Reverse Recovery Charge		Q _{rr}	dl _F /dt = 100A/µs		0.88		μC	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

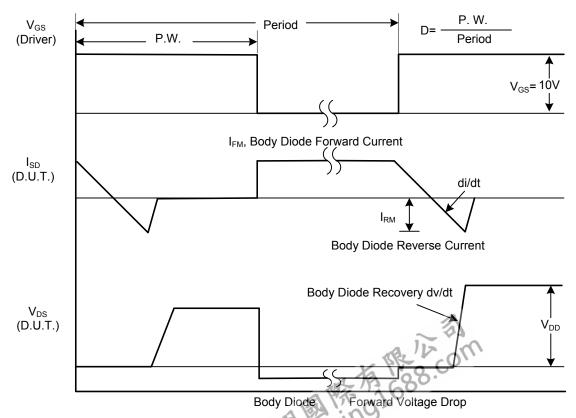
^{2.} Essentially independent of operating temperature.



■ TEST CIRCUITS AND WAVEFORMS

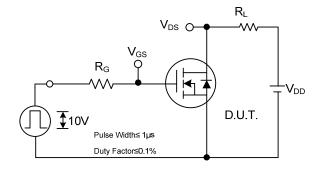


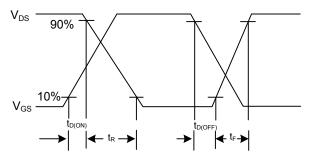
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dwdt Waveforms

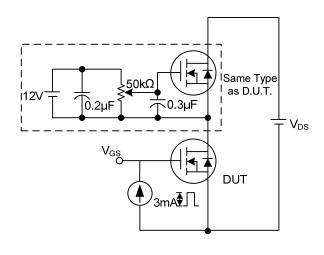
TEST CIRCUITS AND WAVEFORMS (Cont.)

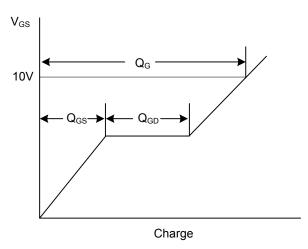




Switching Test Circuit

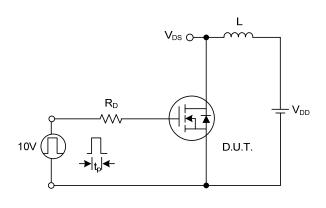
Switching Waveforms

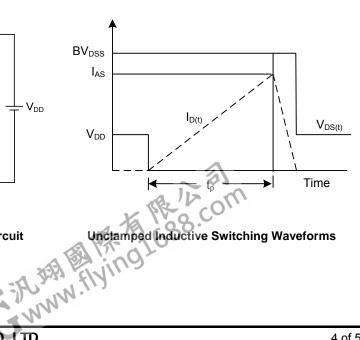




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

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